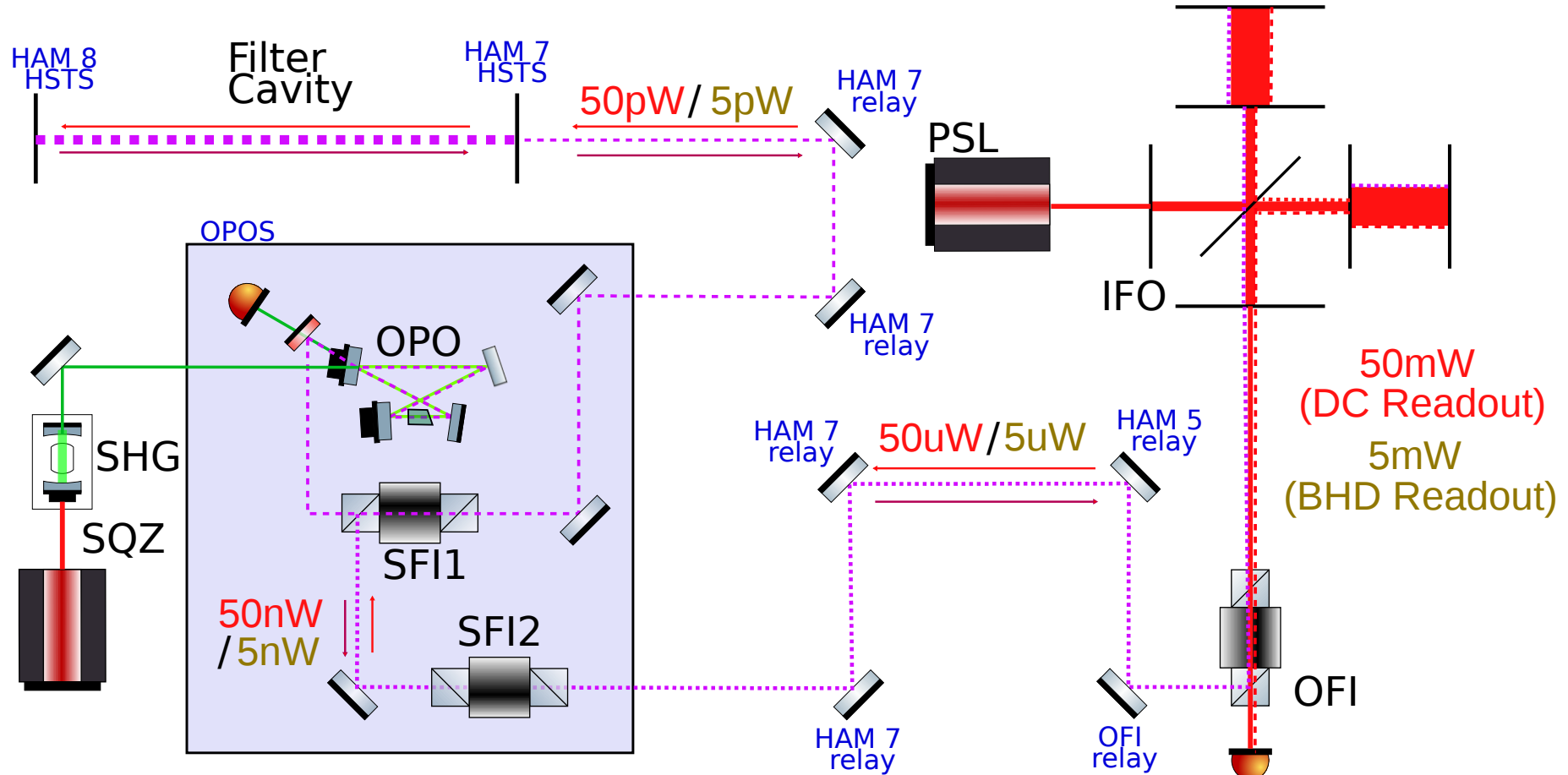


# Scatter in Filter Cavities (and some modeling thoughts)

Lee McCuller  
GWADW 2019

# The basic problem

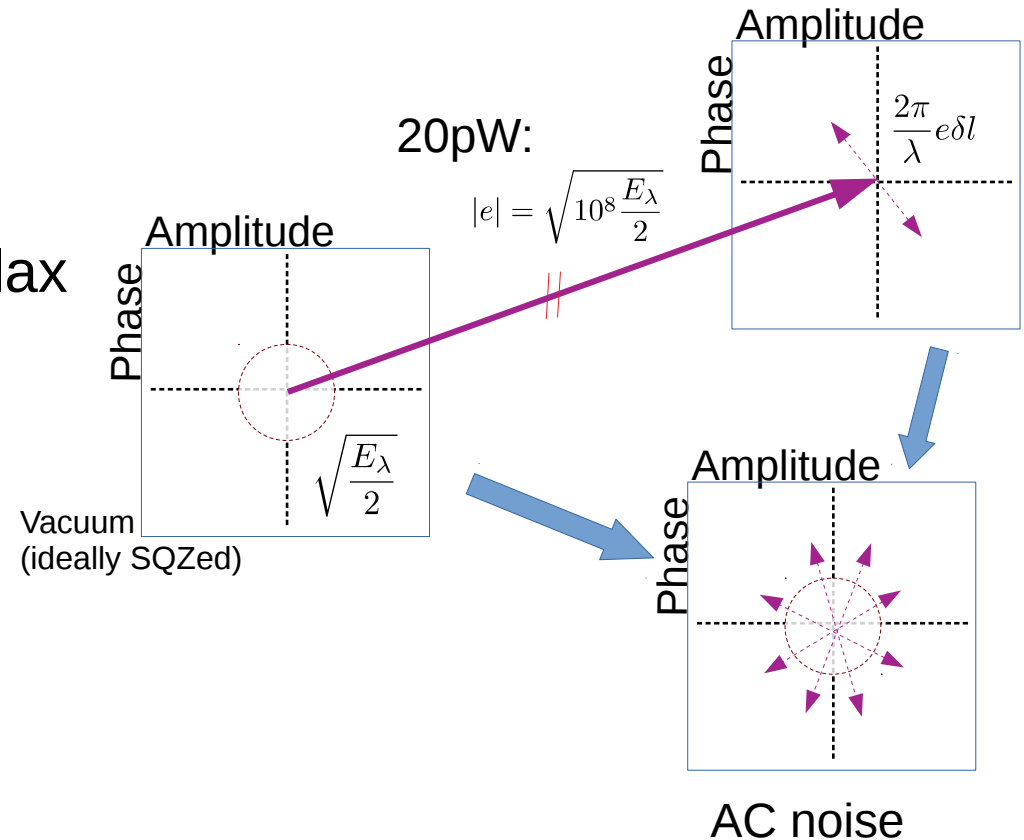
- Faraday Isolators isolate only so well (30-40db)
- The filter cavity is high finesse ( $\sim 5000$  for 300m)
- IFO's should be "quantum limited"



# Requirements Drivers

To motivate simulation needs and “integrated approach” methods

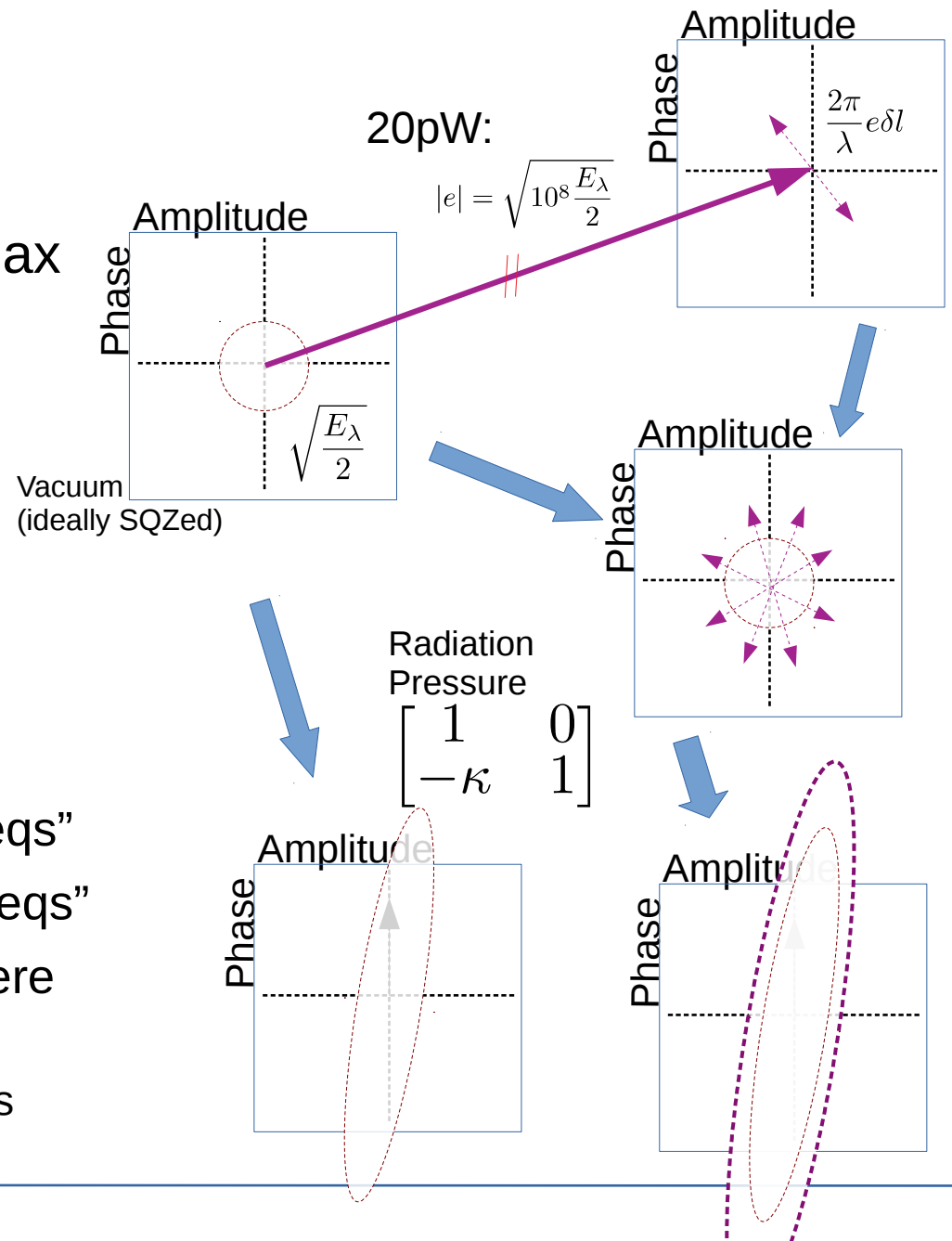
- (Back)scatter is arbitrary in phase [unconstrained by control]
- Scatter field transforms same as vacuum – RPN curve does **NOT** relax requirements
  - Relay optics displacement noise
  - Filter Cavity length noise
    - Direct noise
    - Sensing/Witness noise injection!
  - Filter Cavity BRDF Scatter
- Three approaches
  - Analytic: “What are/How can I meet reqs”
  - Simulated/Integrated: “Am I meeting reqs”
  - Goal for today? Superintegrated: “where may I not be meeting reqs”
    - Unknown Unknowns → Known Unknowns



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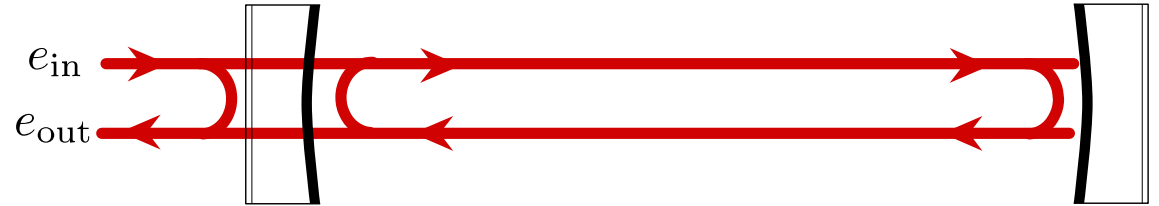
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# Cavity Calculations

- Could use modeling software..

- But analytic calcs good for documentation



- Ad-hoc

- DC cavity field calculations easy
- Derivatives are easy
- AC cavity calculations more tedious (more parameters)
  - Must be simplified/decomposed afterwards
- DC + Derivatives + synthesized AC
  - Start decomposed
  - Trust Kramers-Kronig for equivalence
  - Should do both and check with model

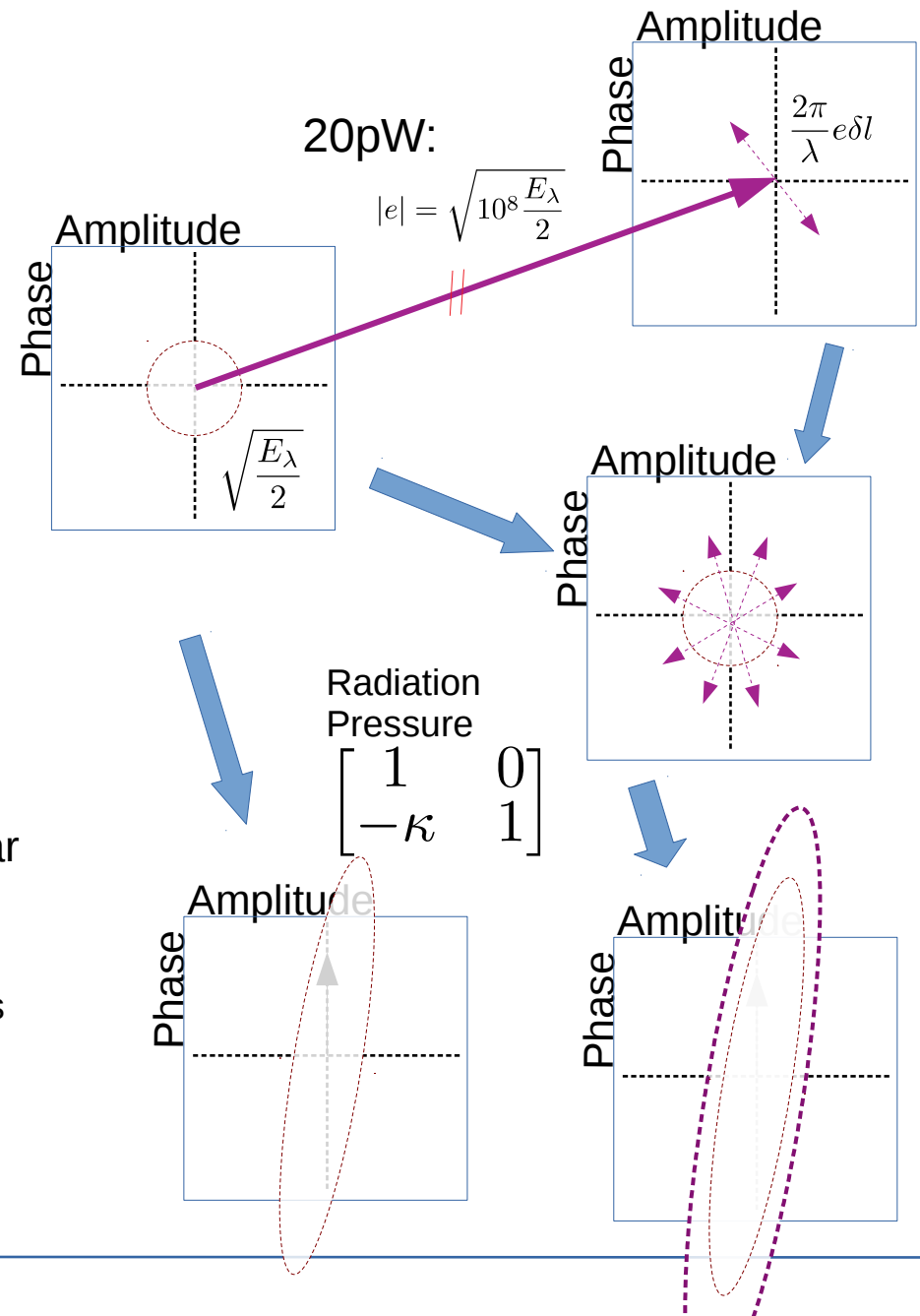
$$\delta_L e = \frac{d}{dL} e_{out} = \frac{2ic}{\lambda f_{pole} L_{cavity}} e_{in}$$

$$H_{pole}(f) = \frac{if_{pole}}{f_{carrier} + if_{pole} - f}$$

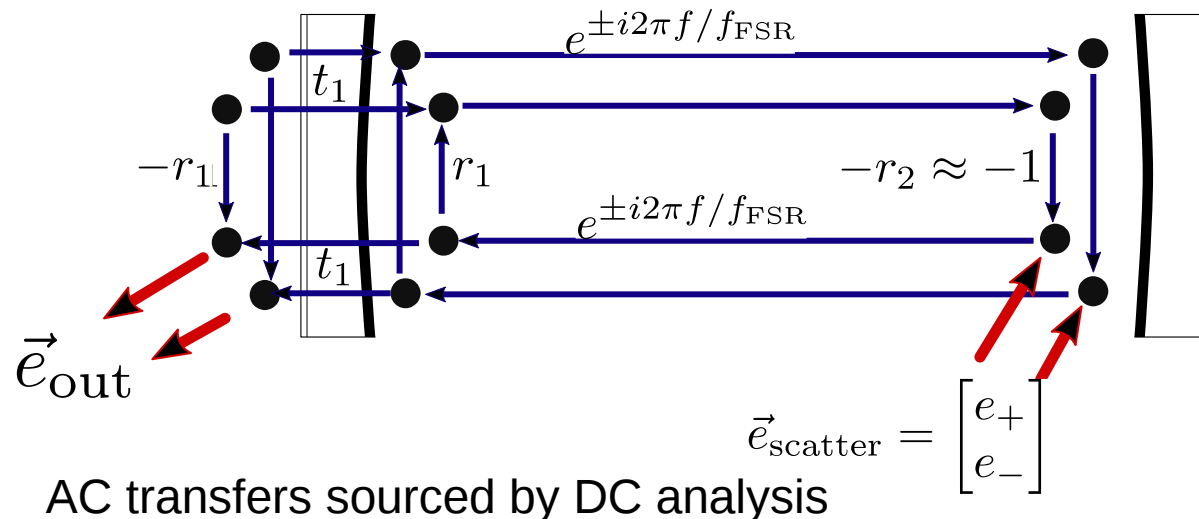
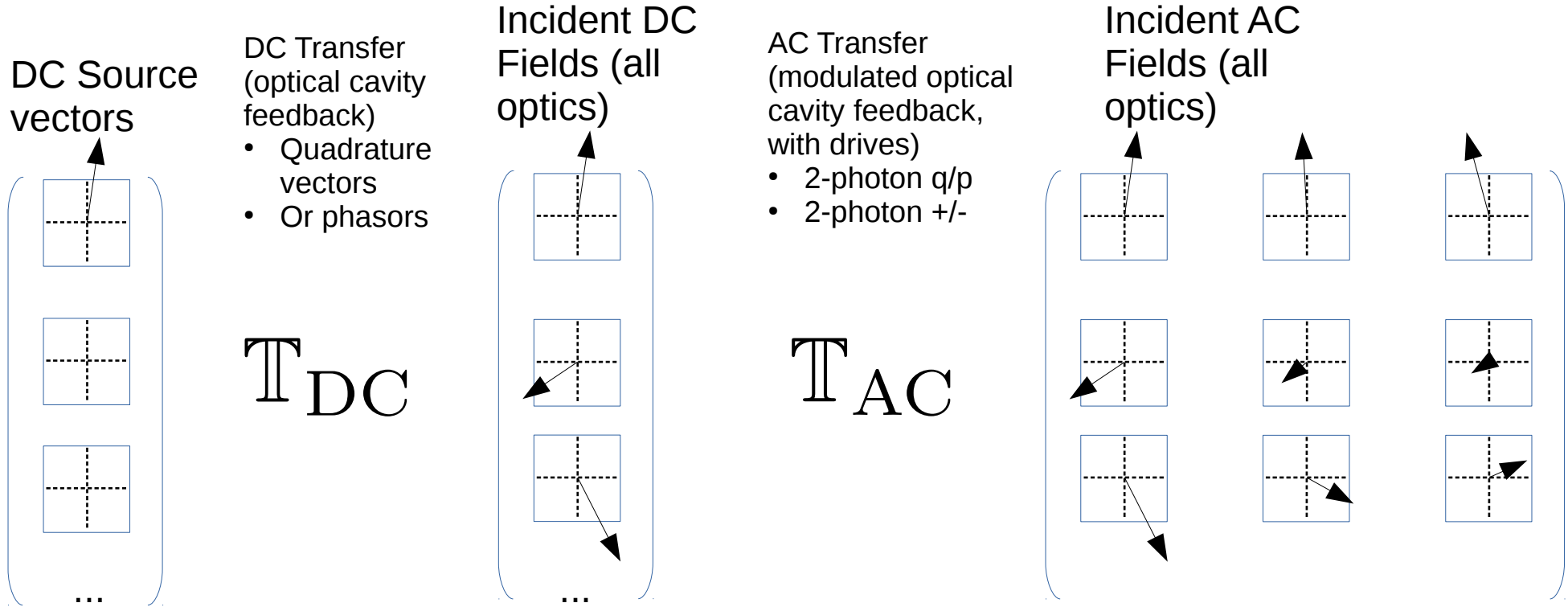
$$|\delta_L^{det} e| = \left( |H_{pole}(f_{det} + f)|^2 + |H_{pole}^*(f_{det} - f)|^2 \right)^{1/2} |H_{pole}(f_{det})| |\delta_L e|$$

# Modeling Thoughts

- Analytic modeling is flexible
  - Many cases/classes of components can be reasoned about simultaneously
  - Requires cross checking, no test suite
- Simulators are combinatorially \*complex\* (like real instruments)
  - Single output projection for many D.O.F.s
  - But show most optical nonlinearity if parameters are scanned/modelled (this can be slow)
- Need more tools for combinatoric/incoherent tolerancing noise
  - Relay phase noise is actually a (frequency dependent) example of this
  - Implementing generic noise drives of incoherent nature (just like quantum noise) can model all linear tolerances and some quadratic (like SQZ phase noise)
    - Fast to compute, matrix implementation means budgets are possible
  - MCMC over tolerances
    - Corner plots are great, but need intelligent collection of parameters



# Coherent Cavity Calculations

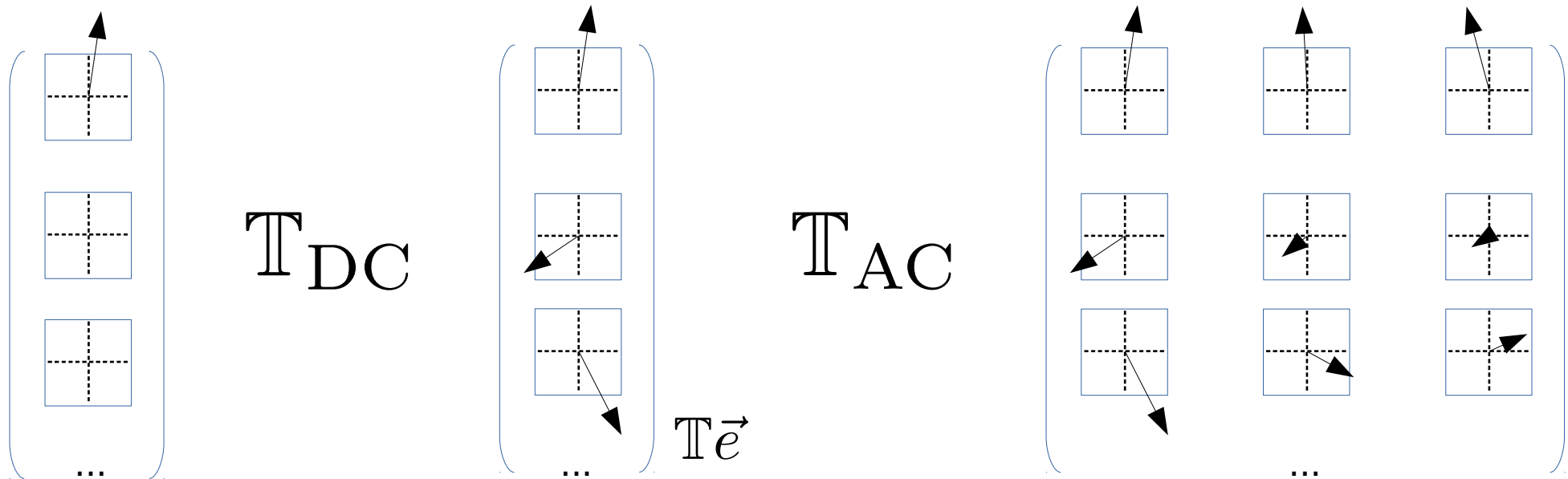


$$\vec{e}_{out} = \mathbb{T}(f) \vec{e}_{scatter}$$

$$USV = \mathbb{T}(f)$$

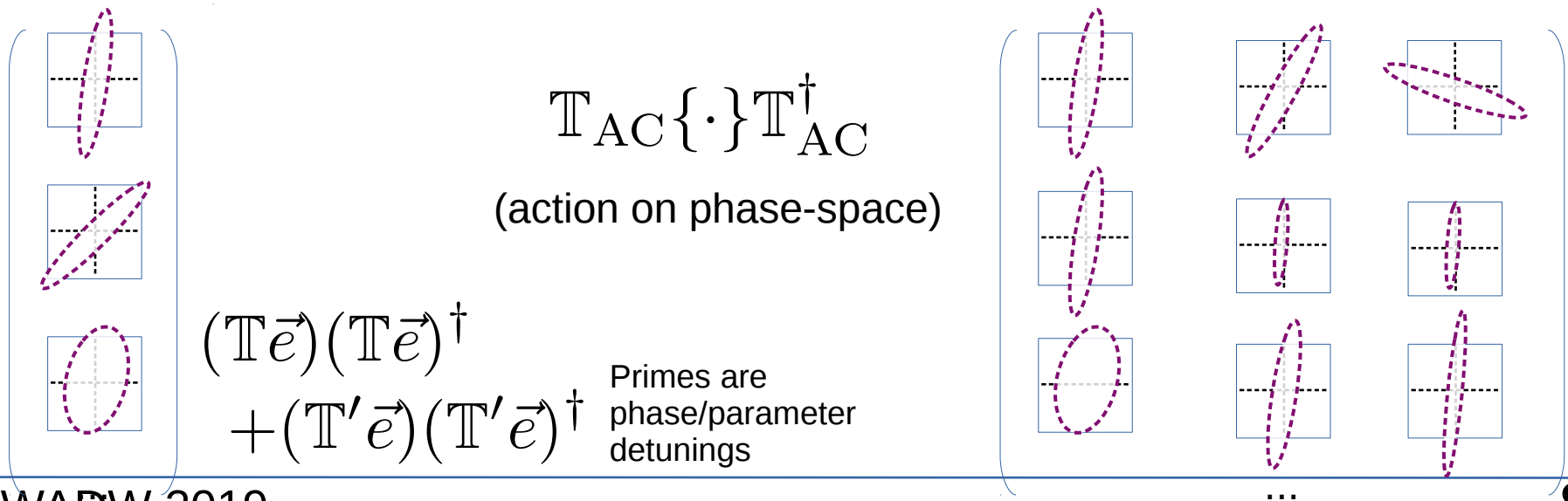
SVD of subspaces gives phase-indep. Gains in S, phases in UV, can be useful

# Incoh Cavity Calculations



Phase-space like representation of DC sources

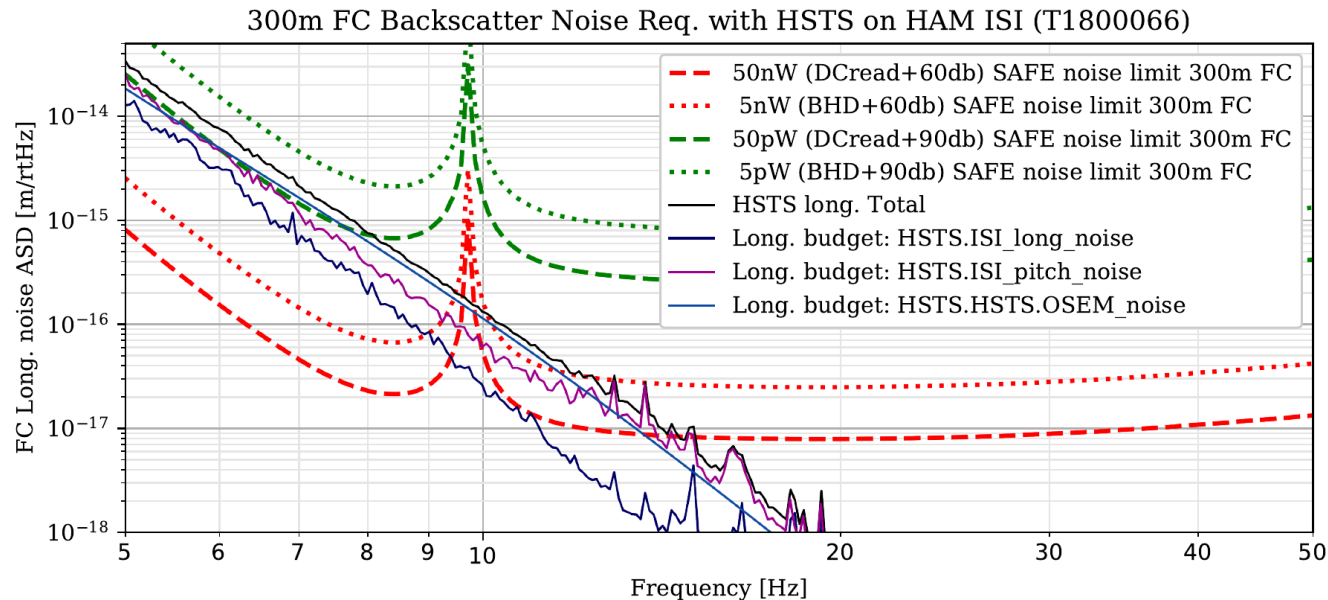
This is essentially the same as QN calculations





# Length Noise Modelling

- Using actual measured SEI performance, rather than original design requirements (as our SEI outperforms them).
- SEI Spectra + SUS state-space → length noise budget
  - Need reference spectra
  - State space representations
    - quite concise,
    - easy to simulate,
    - probably good for MCMC, more advanced sim tools
  - Need reference output with safety factor (used GWINC)



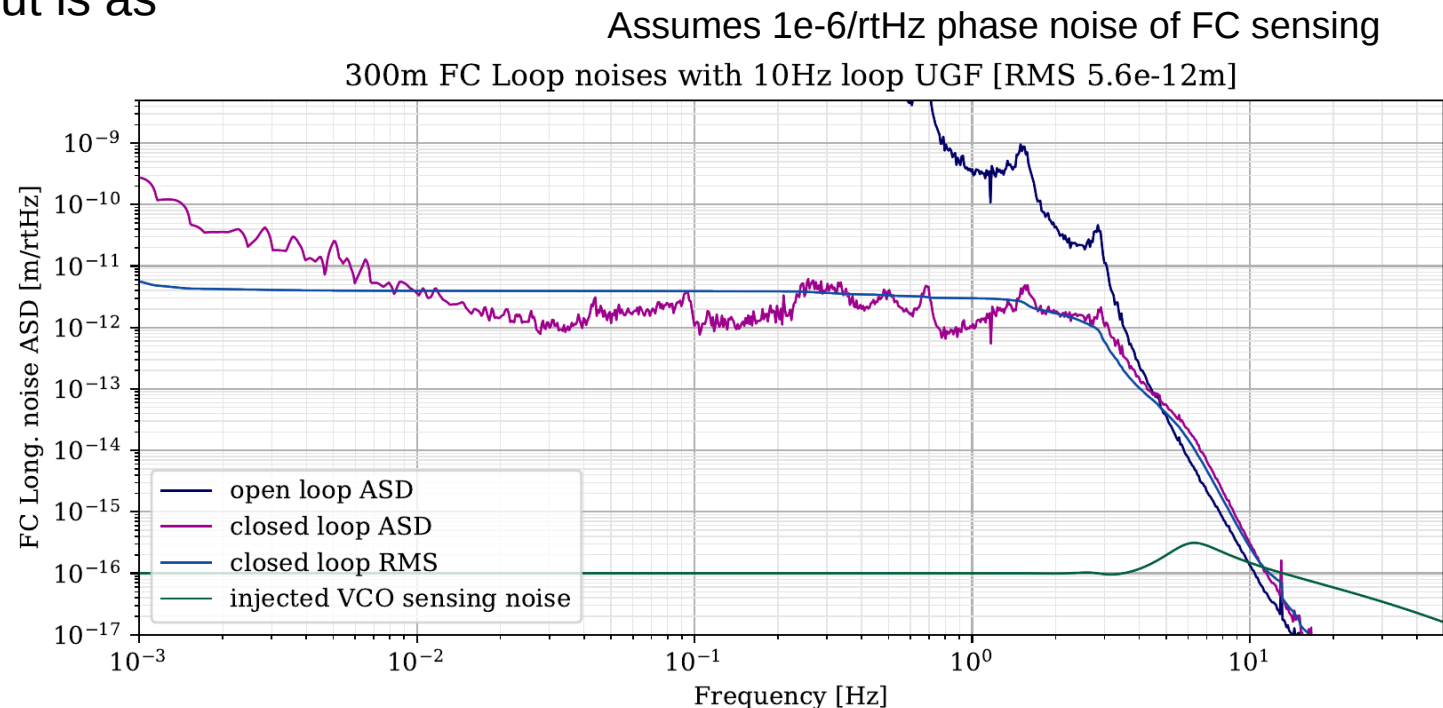
# Why the phase noise requirement?

- Need end-to-end loop modeling!
  - Alignment sensing needs this far more desperately
- ALL measurements are differential, but how inertial is your reference?
  - In this case, the length-sensing field laser is not a freq. Reference
  - But the IFO filtered output is as stable as CARM motion
  - Must lock the two

(Need a simulator with noise budgets That are intelligible for J. Driggers realistic alignment-sensing-control (ASC) diagrams, full IFO complexity)

This is an example of a subtle req. hiding In the control system for just a single degree of freedom.

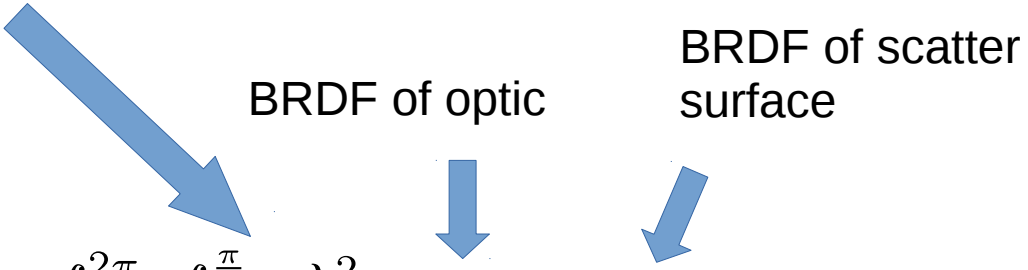
Highly shaped loop meets RMS reqs, but not with much margin for rolloff of sensing noise



# Diffuse Scatter

- Forward/Reverse coupling follow an A-omega diffraction-limited collection area law (T940063 Flanagan, Thorne)
- Can ignore optical field strengths! (optical sensitivity is separable problem)

Scattering "power"


$$S_{\text{diffuse}}^2 = \int_0^{2\pi} \int_0^{\frac{\pi}{2}} \frac{\lambda^2}{r^2(\theta)} B_{\text{optic}}^2(\theta) B_{\text{surface}}(\theta + X) \sin(\theta) d\theta d\phi$$

Power-like Unitless Coupling for Amplitude Spectral Densities

$$\delta L_{\text{cav}} = S_{\text{diffuse}} \delta L_{\text{surface}}$$

# Analytic Approach

- A: Filter cavity has enormously relaxed length sensitivity than the arms
  - Allows a worst-case analysis
- B: Usual approach worries that small angle scatter is large (from low-k mirror irregularities)

$$B_{\text{optic}}(\theta) \propto \frac{1}{\theta^N}$$

- But! Assume/know total mirror scatter is small/bounded

$$L_{\text{scatter}} = 2\pi \int_0^{\frac{\pi}{2}} B_{\text{optic}}(\theta) \sin(\theta) d\theta < 50\text{ppm}$$

Must have some  $\theta_{\text{min}}$  cutoff scale, and be limited in scatter coefficient

# Worst-Case Analysis

- Assume BRDF Monotonic
- Assume all scatter is in a disc at some cutoff
- Geometry mostly in  $r(\theta, \phi)$

$$B_{\text{optic}}(\theta) = \begin{cases} \alpha & \theta < \theta_{\min} \\ \beta \cos(\theta) & \theta > \theta_{\min} \end{cases}$$

$$\alpha \approx \frac{50\text{ppm}}{2\pi\theta_{\min}^2} \quad \beta \approx 50\text{ppm}$$

Now relatively tractable to evaluate for many geometries

$$S_{\text{diffuse}}^2 = \int_0^{2\pi} \int_0^{\frac{\pi}{2}} \frac{\lambda^2}{r^2(\theta, \phi)} B_{\text{optic}}^2(\theta) B_{\text{surface}}(\theta + X) \sin(\theta) d\theta d\phi$$

Entirely Geometric - Scatter surface modeling can be separated from optical sensitivity.

Generally shows that near walls/baffles dominate from  $\frac{1}{r^2}$   
(contradicts arm-tube analysis?)

# Conclusions

- Still useful to use analytic calculation to search parameter spaces, find solutions
- Useful to check all cases of chosen realization through simulation
  - Need tools to help here
- Diffuse scatter more a geometric problem, but plugs into optical sensitivities (determinable through incoherent simulation)
  - Is diffuse modeling fully separable?
  - Backscatter not separable, but also less geometric.
  - Specular scatter geometric, is it separably modellable
- (squeezed) shotnoise-limited field sensitivity sufficient for output backscatter calculations
  - Radiation Pressure effect “ignorable” (must use worst case)
  - (but does not relax reqs. W.R.T. SN.)
- Unmodelled sensing noise isn’t necessarily a scatter problem, but (more total) controls modeling may prevent design flaws.
  - Want to drive this point for future ASC design